

# OptiMOS™-5 Power-Transistor





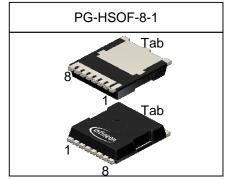
#### **Features**

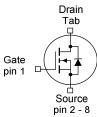
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- Ultra low Rds(on)
- 100% Avalanche tested

Туре	Package	Marking
IAUT165N08S5N029	PG-HSOF-8-1	5N08029

#### **Product Summary**

V <sub>DS</sub>	80	V
R <sub>DS(on)</sub>	2.9	mΩ
I <sub>D</sub>	165	Α





## **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10V <sup>1)</sup>	165	А
		T <sub>C</sub> =100 °C, V <sub>GS</sub> =10 V <sup>2)</sup>	120	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	660	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	I <sub>D</sub> =83 A	225	mJ
Avalanche current, single pulse	IAS	-	165	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	167	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	0.9	K/W

# **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

## Static characteristics

Drain-source breakdown voltage <sup>2)</sup>	$V_{(BR)DSS}$	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	80	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 108  \mu {\rm A}$	2.2	3	3.8	
Zero gate voltage drain current <sup>2)</sup>	I <sub>DSS</sub>	V <sub>DS</sub> =80 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	1	0.1	1	μA
		$V_{DS}$ =50 V, $V_{GS}$ =0 V, $T_{j}$ =85 °C <sup>2)</sup>	-	1	20	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =6 V, I <sub>D</sub> =40 A	-	2.9	4.4	mΩ
		V <sub>GS</sub> =10 V, I <sub>D</sub> =80 A	-	2.4	2.9	



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	4900	6370	pF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =40 V, f=1 MHz	-	790	1027	1
Reverse transfer capacitance	C <sub>rss</sub>		-	36	54	
Turn-on delay time	$t_{d(on)}$		-	13	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =40 V, V <sub>GS</sub> =10 V,	-	9	-	
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =100 A, $R_{\rm G}$ =3.5 Ω	-	23	-	
Fall time	$t_{\mathrm{f}}$	1	-	29	-	
Gate Charge Characteristics <sup>2)</sup> Gate to source charge	Q <sub>gs</sub>		_	24	31	nC
Gate to drain charge	Q gs	., ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		15	23	
Gate charge total	Q <sub>g</sub>	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V	-	70	90	
Gate plateau voltage	V <sub>plateau</sub>		-	5.0	-	V
Reverse Diode	ı	<u>'</u>		l		
Diode continous forward current <sup>2)</sup>	Is	T -25 °C	-	-	165	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> =25 °C	1	-	660	
Diode forward voltage	$V_{\mathrm{SD}}$	V <sub>GS</sub> =0 V, I <sub>F</sub> =100 A, T <sub>j</sub> =25 °C	-	0.9	1.2	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =40 V, I <sub>F</sub> =50A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs	-	60	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>			96	_	nC

 $<sup>^{1)}</sup>$  Current is limited by bondwire; with an  $R_{\rm thJC}$  = 0.9 K/W the chip is able to carry 171A at 25°C.

<sup>&</sup>lt;sup>2)</sup> Defined by design. Not subject to production test.

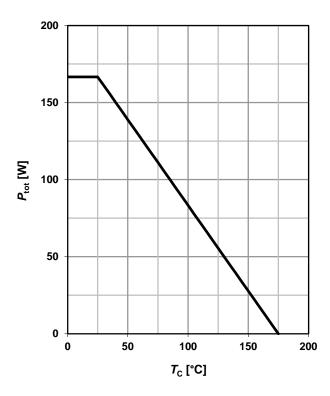


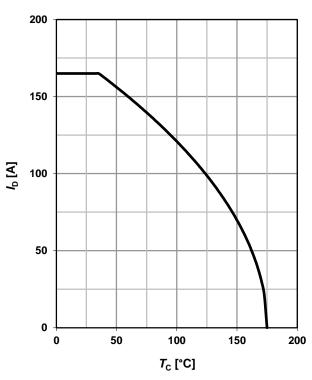
#### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

## 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$





## 3 Safe operating area

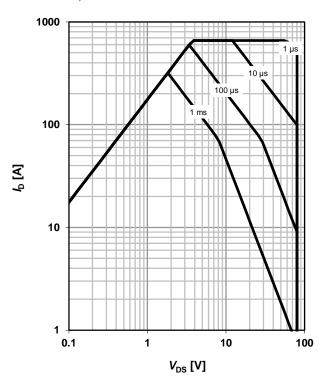
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

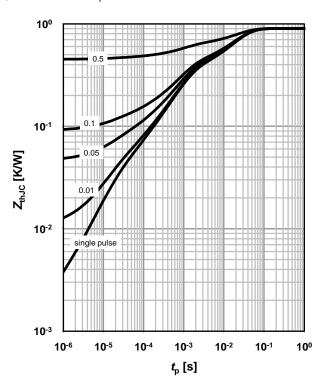
parameter:  $t_p$ 

#### 4 Max. transient thermal impedance

$$Z_{thJC} = f(t_p)$$

parameter:  $D=t_p/T$ 







## 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$ 

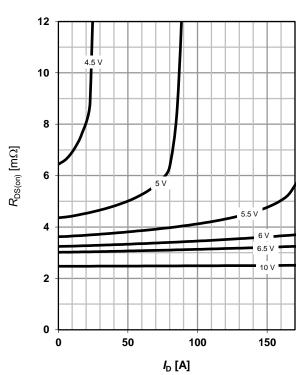
parameter:  $V_{\rm GS}$ 

# 700 525 350 175 0 0 1 2 3 4 5 6 7 V<sub>DS</sub> [V]

#### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ °C}$ 

parameter: V<sub>GS</sub>



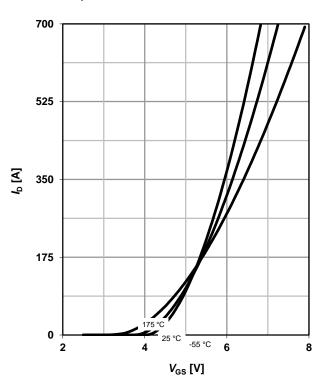
## 7 Typ. transfer characteristics

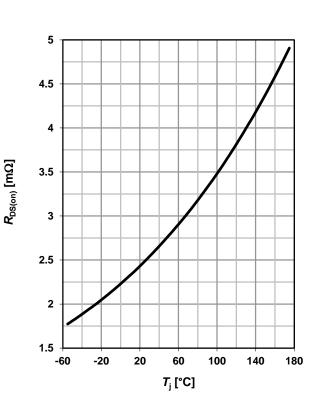
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter: T<sub>i</sub>

## 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}$$







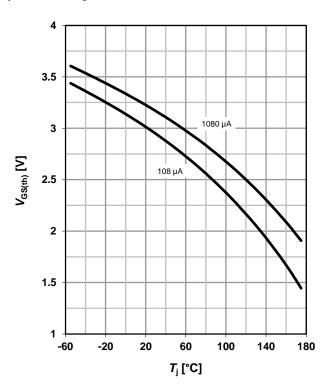
#### 9 Typ. gate threshold voltage

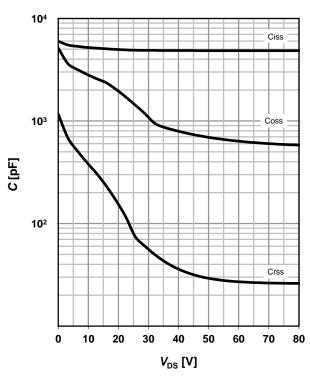
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

## 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 





#### 11 Typical forward diode characteristicis

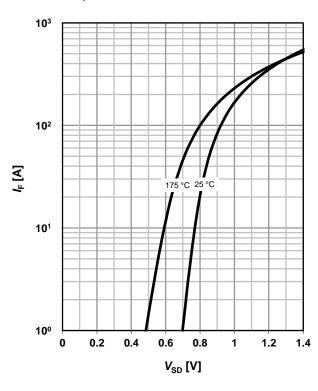
 $IF = f(V_{SD})$ 

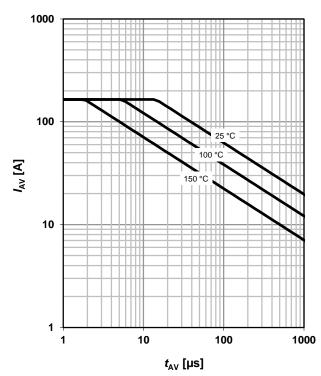
parameter: T<sub>i</sub>

#### 12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>







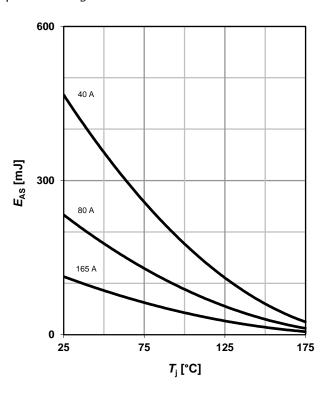
## 13 Typical avalanche energy

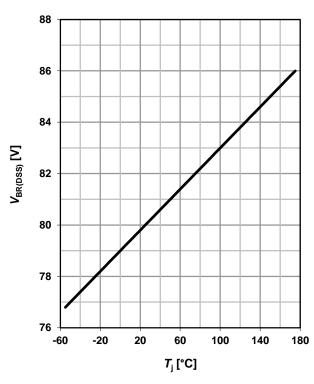
 $E_{AS} = f(T_i)$ 

parameter:  $I_D$ 

#### 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_{D_{typ}} = 1 \text{ mA}$$

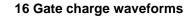


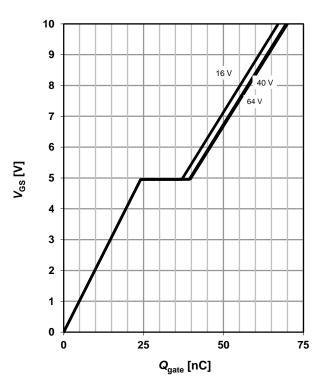


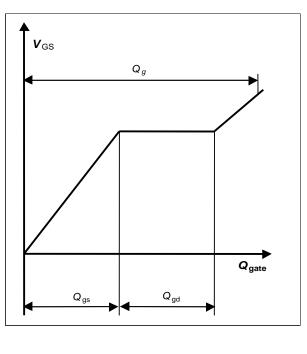
## 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 100 A pulsed$ 

parameter:  $V_{\rm DD}$ 









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If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



## Revision History

Version	Date	Changes
Version 1.0	29.11.2016	Final Data Sheet
Version 1.1	26.04.2023	Clarified naming